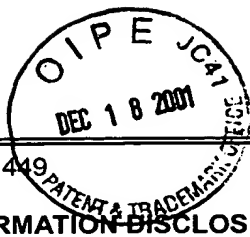


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				Applicant Stephan W. WEGERICH et al.				
				Filing Date February 12, 2001		Group Art Unit 2123		
U. S. PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER			DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.
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FOREIGN PATENT DOCUMENTS								
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	Translation Yes No		
OTHER DOCUMENTS <small>(Including Author, Title, Date, Pertinent Pages, Etc.)</small>								
T.P.	"MSET Modeling Of Crystal River-3 Venturi Flow Meters" by J. P. Herzog, S. W. Wegerich,							
	K. C. Gross, and F. K. Bockhorst, 6th International Conference on Nuclear Engineering, ICONE-6169,							
	May 10-14, 1998, Copyright © 1998 ASME (12 pp).							
EXAMINER Thai Phan					DATE CONSIDERED 3/1/04			
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EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.			
T.P.	3	0	4	5	2	2	1	07/17/62	Roop						
T.P.	R	e	3	1	7	5	0	11/27/84	Morrow						
T.P.	5	5	8	6	0	6	6	12/17/96	White et al.						
T.P.	5	7	7	4	3	7	9	06/30/98	Gross et al.						
T.P.	5	9	8	7	3	9	9	11/16/99	Wegerich et al.						
FOREIGN PATENT DOCUMENTS															
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T.P.	WO 00/67412							11/09/00	PCT	—	—				
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T.P.	"Application Of A New Technique For Modeling System Behavior" by Paul J. O'Sullivan, presented at the ISA Symposium, Edmonton, Alberta, May 1, 1991, © Copyright 1991 Instrument Society of America (21 pp.)														
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T.P.	ModelWare™ Product Review by Robert D. Flori, reprinted from Computerized Investing, September/October 1992, Volume XI, No. 5, copyright by The American Association of Individual Investors (pp. 8-10)														
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T.P.	ModelWare™ A New Approach to Prediction by Ken Tucker, reprinted from PC AI magazine, January/February 1993, pp. 14, 15, 30												
T.P.	"Similarity Based Regression: Applied Advanced Pattern Recognition for Power Plant Analysis," by E. J. Hansen and M. B. Caudill, presented at the 1994 EPRI Heat Rate Improvement Conference (9 pp.)												
T.P.	"Applied Pattern Recognition For Plant Monitoring And Data Validation," by Ron Griebenow, E. J. Hansen, and A. L. Sudduth, presented at the Fifth International Joint ISA POWID/EPRI Controls and Instrumentation Conference, La Jolla, California, June 19-21, 1995 (11 pp.)												
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